


<b>Search Notes</b> 	<b>Application/Control No.</b> 10751056	<b>Applicant(s)/Patent Under Reexamination</b> DIPIANO ET AL.
	<b>Examiner</b> Kim, Jennifer	<b>Art Unit</b> 1617

SEARCHED			
Class	Subclass	Date	Examiner
514	899	3/30/2007	jmk
424	430	3/30/2007	jmk
	updated	10/28/2007	jmk

SEARCH NOTES		
Search Notes	Date	Examiner
inventor search; STN, WEST	3/30/2007	jmk
updated;STIC	10/28/2007	jmk

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner